

General Description

This planar stripe MOSFET has better characteristics, such as fast switching time, low on resistance, low gate charge and excellent avalanche characteristics. It is mainly suitable for electronic ballast and switching mode power supplies.

FEATURES

- $V_{DSS} = 600V$, $I_D = 3A$
- Drain-Source ON Resistance : $R_{DS(ON)} = 3.3\Omega$ @ $V_{GS} = 10V$
- $Q_g(\text{typ}) = 8.5nC$

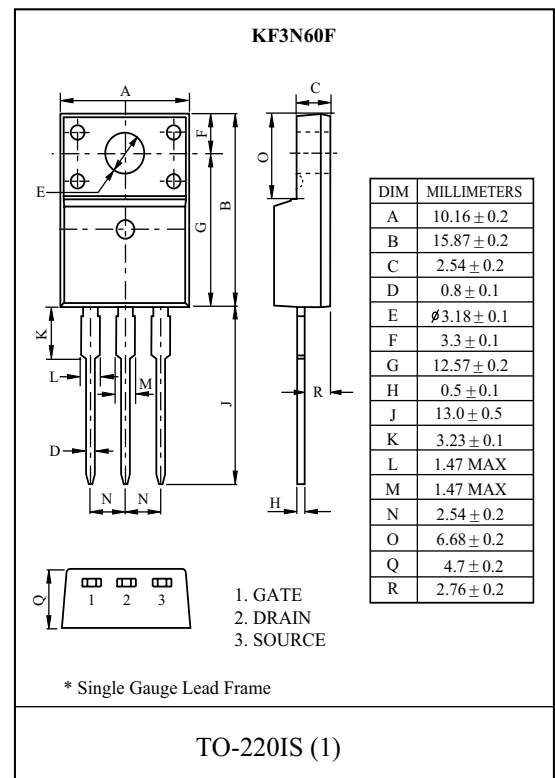
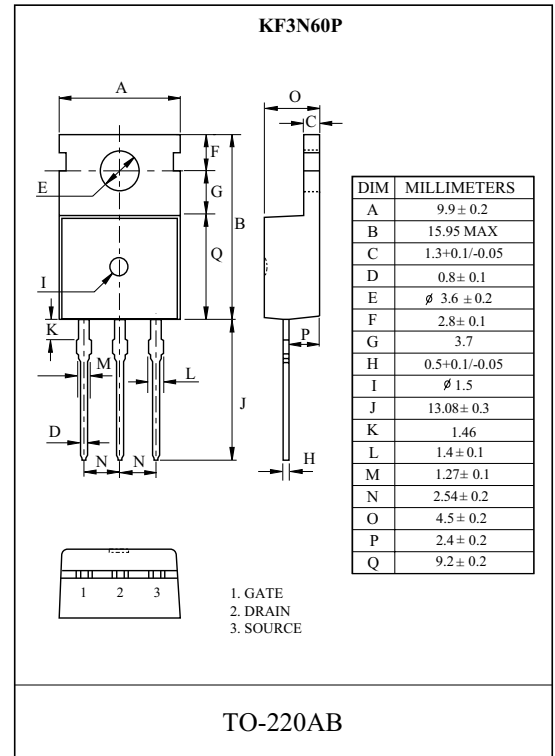
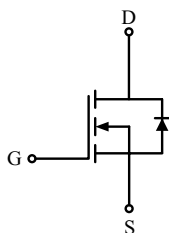
MAXIMUM RATING (Ta=25°C)

CHARACTERISTIC	SYMBOL	RATING		UNIT	
		KF3N60P	KF3N60F		
Drain-Source Voltage	V_{DSS}	600		V	
Gate-Source Voltage	V_{GSS}	± 30		V	
Drain Current	@ $T_c = 25^\circ C$	I_D	3	3*	A
	@ $T_c = 100^\circ C$	I_D	1.9	1.9*	
	Pulsed (Note1)	I_{DP}	7	7*	
Single Pulsed Avalanche Energy (Note 2)	E_{AS}	120		mJ	
Repetitive Avalanche Energy (Note 1)	E_{AR}	3.2		mJ	
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5		V/ns	
Drain Power Dissipation	$T_c = 25^\circ C$	P_D	73	31	W
	Derate above 25°C	P_D	0.58	0.25	W/°C
Maximum Junction Temperature	T_j	150		°C	
Storage Temperature Range	T_{stg}	-55 ~ 150		°C	
Thermal Characteristics					
Thermal Resistance, Junction-to-Case	R_{thJC}	1.7	4	°C/W	
Thermal Resistance, Junction-to-Ambient	R_{thJA}	62.5	62.5	°C/W	

* : Drain current limited by maximum junction temperature.

PIN CONNECTION

(KF3N60P, KF3N60F)



KF3N60P/F

ELECTRICAL CHARACTERISTICS (Ta=25 °C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu A, V_{GS}=0V$	600	-	-	V
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_j$	$I_D=250\mu A$, Referenced to 25 °C	-	0.61	-	V/°C
Drain Cut-off Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$,	-	-	10	μA
Gate Threshold Voltage	V_{th}	$V_{DS}=V_{GS}, I_D=250\mu A$	2.5	-	4.5	V
Gate Leakage Current	I_{GSS}	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	± 100	nA
Drain-Source ON Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=1.5A$	-	2.8	3.3	Ω
Dynamic						
Total Gate Charge	Q_g	$V_{DS}=480V, I_D=3A$ $V_{GS}=10V$ (Note4,5)	-	8.5	-	nC
Gate-Source Charge	Q_{gs}		-	1.8	-	
Gate-Drain Charge	Q_{gd}		-	3.6	-	
Turn-on Delay time	$t_{d(on)}$	$V_{DD}=300V$ $I_D=3A$ $R_G=25\Omega$ (Note4,5)	-	25	-	ns
Turn-on Rise time	t_r		-	25	-	
Turn-off Delay time	$t_{d(off)}$		-	40	-	
Turn-off Fall time	t_f		-	20	-	
Input Capacitance	C_{iss}	$V_{DS}=25V, V_{GS}=0V, f=1.0MHz$	-	355	-	pF
Output Capacitance	C_{oss}		-	45	-	
Reverse Transfer Capacitance	C_{rss}		-	4.4	-	
Source-Drain Diode Ratings						
Continuous Source Current	I_S	$V_{GS}<V_{th}$	-	-	3	A
Pulsed Source Current	I_{SP}		-	-	12	
Diode Forward Voltage	V_{SD}	$I_S=3A, V_{GS}=0V$	-	-	1.4	V
Reverse Recovery Time	t_{rr}	$I_S=3A, V_{GS}=0V$, $dI_S/dt=100A/\mu s$	-	300	-	ns
Reverse Recovery Charge	Q_{rr}		-	1.5	-	μC

Note 1) Repetivity rating : Pulse width limited by junction temperature.

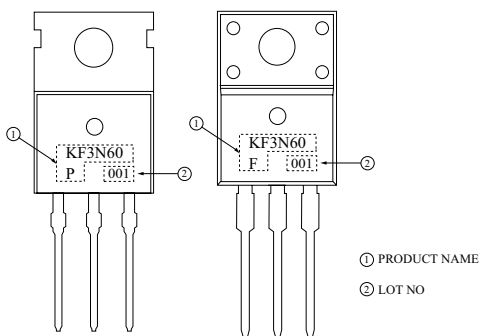
Note 2) L=24.5mH, $I_S=3A$, $V_{DD}=50V$, $R_G=25\Omega$, Starting $T_j=25^\circ C$.

Note 3) $I_S \leq 3A$, $dI/dt \leq 100A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_j=25^\circ C$.

Note 4) Pulse Test : Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

Note 5) Essentially independent of operating temperature.

Marking



K3N60P/F

Fig1. $I_D - V_{DS}$

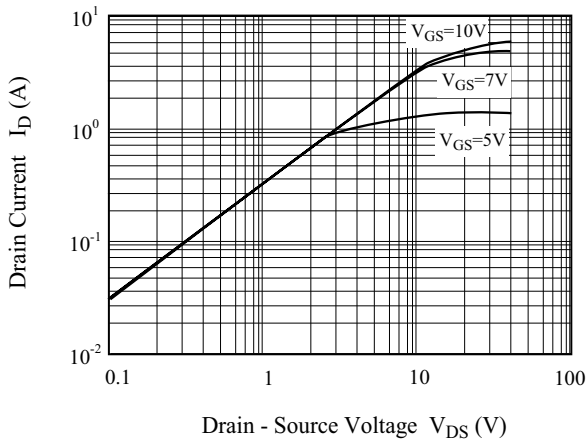


Fig2. $I_D - V_{GS}$

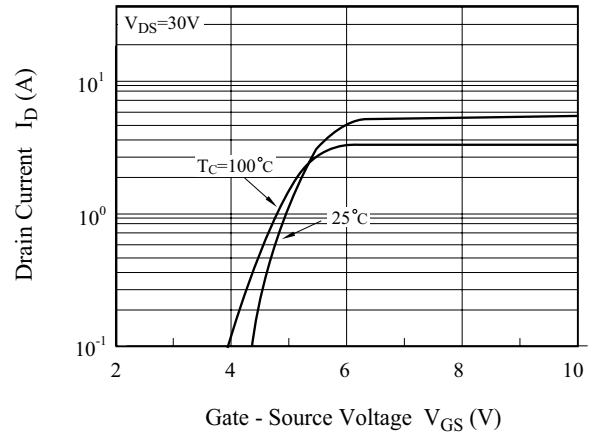


Fig3. $BV_{DSS} - T_j$

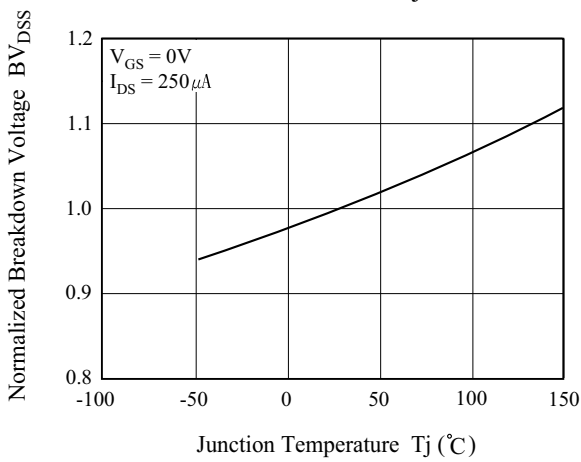


Fig4. $R_{DS(ON)} - I_D$

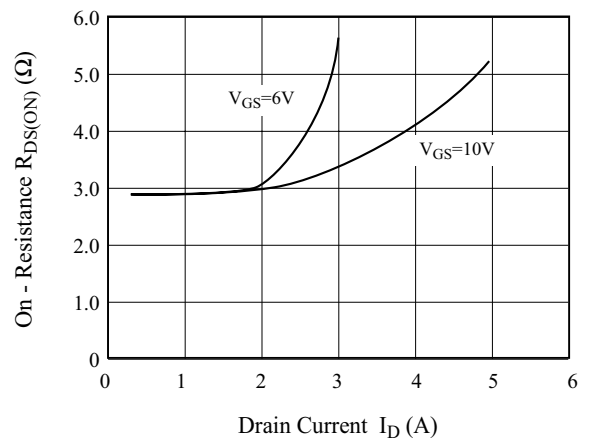


Fig5. $I_S - V_{SD}$

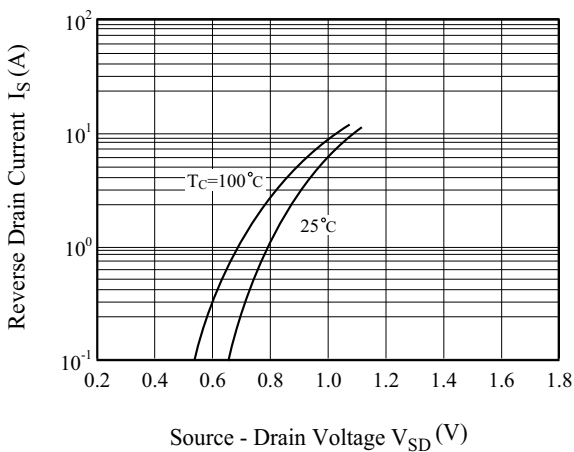
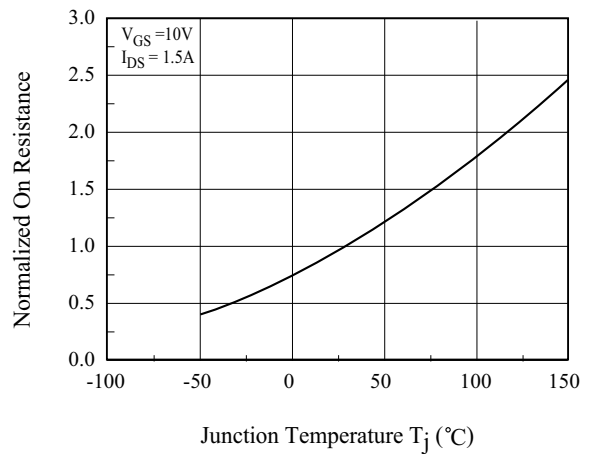


Fig6. $R_{DS(ON)} - T_j$



K3N60P/F

Fig 7. C - V_{DS}

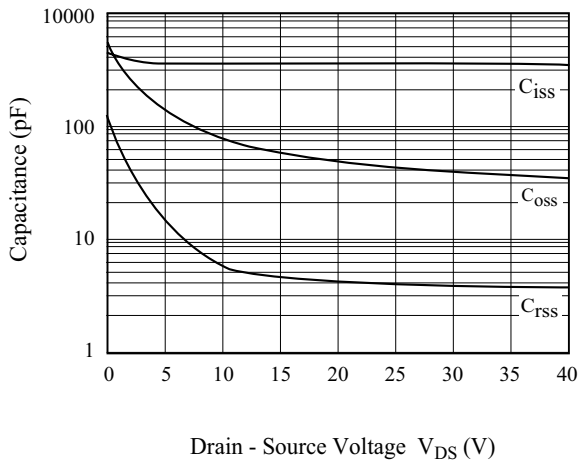


Fig8. Q_g- V_{GS}

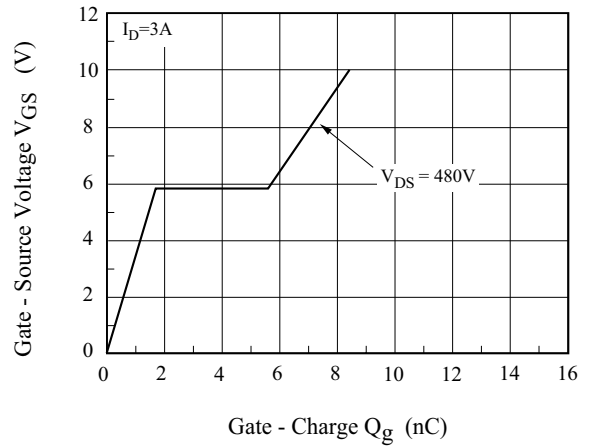


Fig9. Safe Operation Area

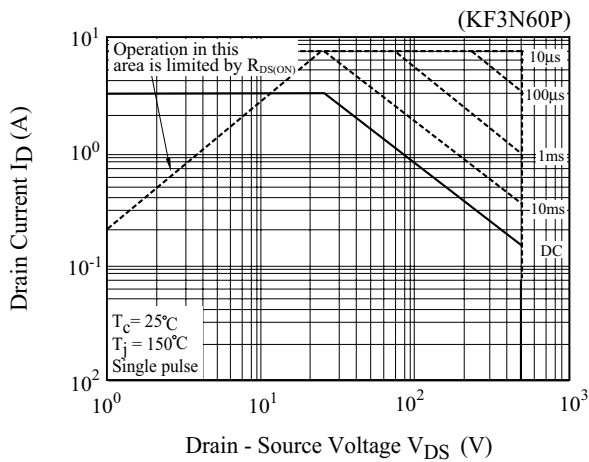


Fig10. Safe Operation Area

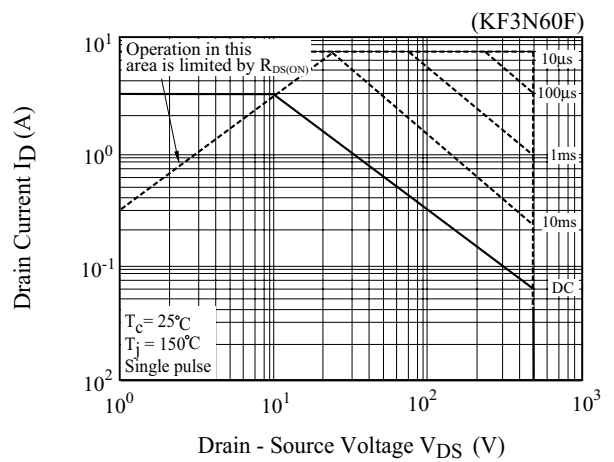
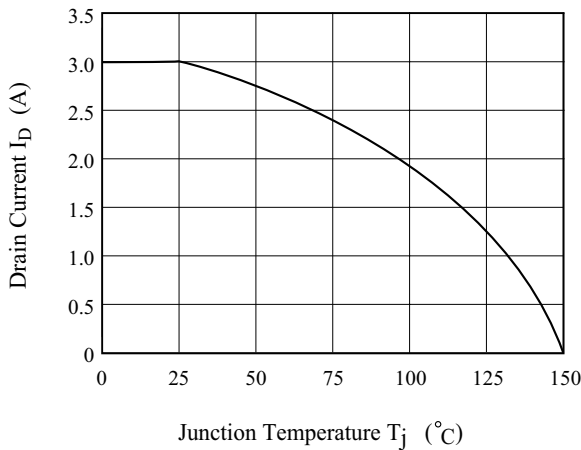


Fig11. I_D - T_j



K3N60P/F

Fig12. Transient Thermal Response Curve

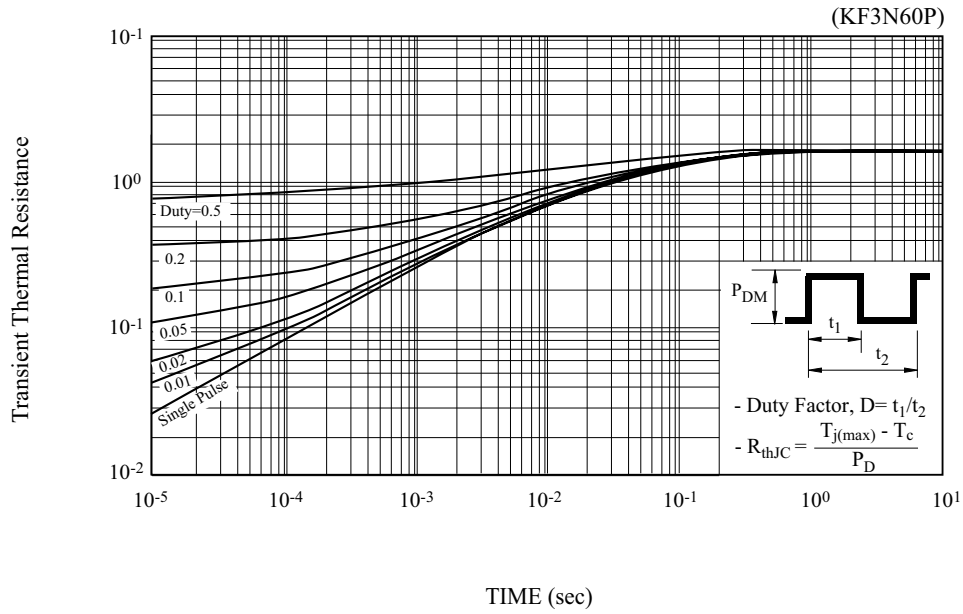
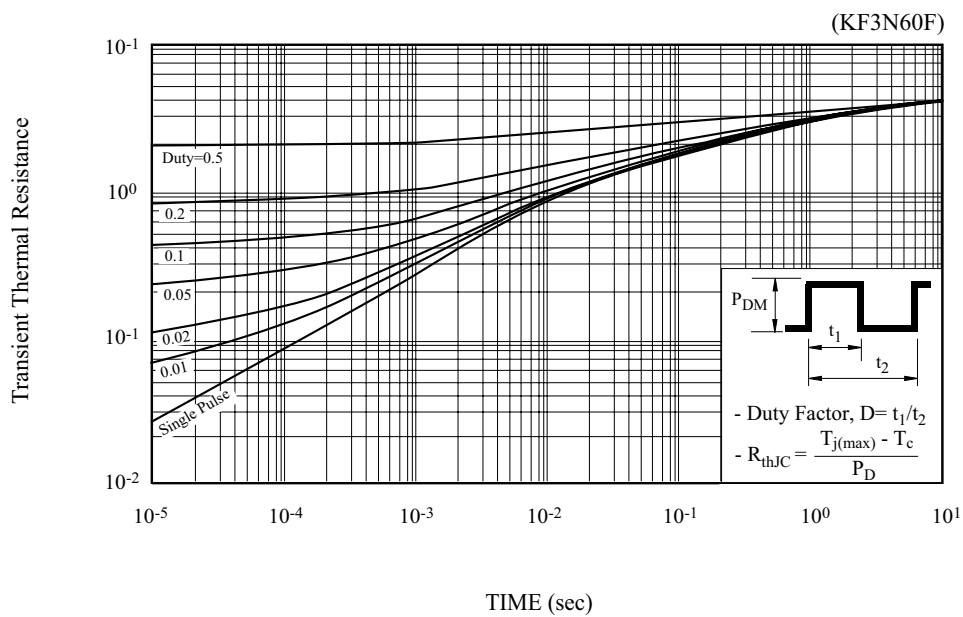


Fig13. Transient Thermal Response Curve



K3N60P/F

Fig14. Gate Charge

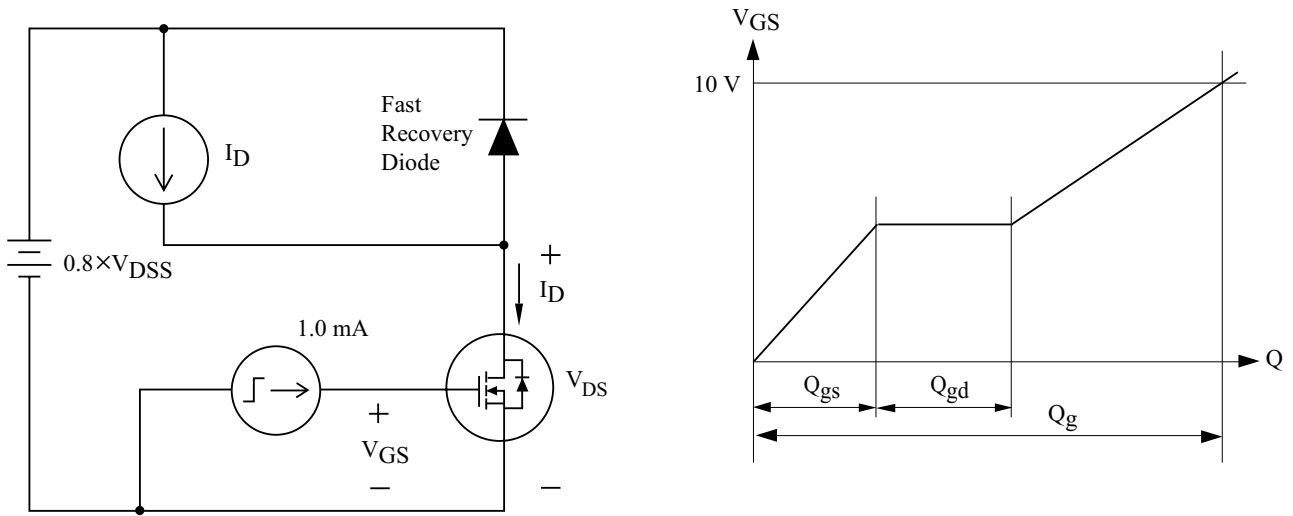


Fig15. Single Pulsed Avalanche Energy

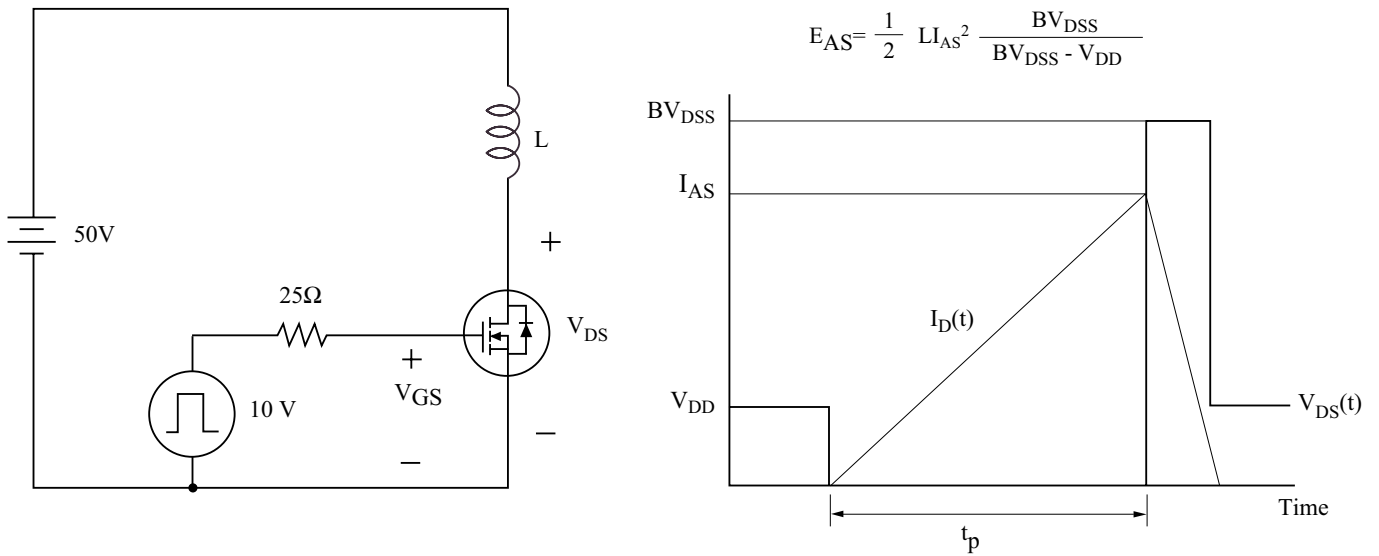
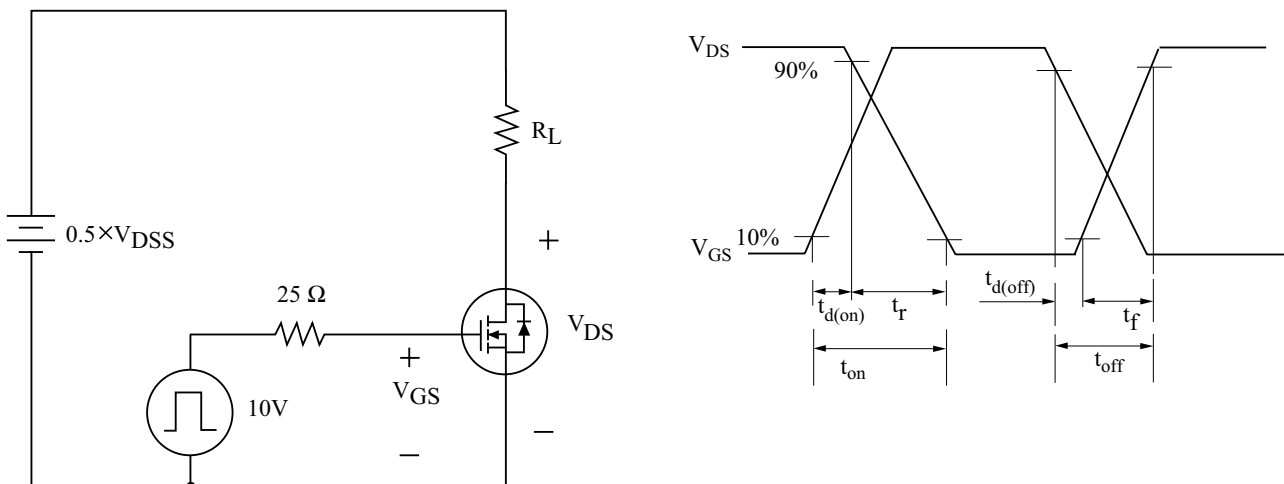


Fig16. Resistive Load Switching



K3N60P/F

Fig17. Source - Drain Diode Reverse Recovery and dv /dt

